

<b>Notice of References Cited</b>	Application/Control No. 10/577,230	Applicant(s)/Patent Under Reexamination ABE ET AL.	
	Examiner Ling-Siu Choi	Art Unit 1796	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,171,413	10-1979	Hartman et al.	525/328.2
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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*	N	JP 62-072742	04-1987	Japan	Abe et al.	--
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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